

Notice of References Cited

Application/Control No.

09/842,139

Applicant(s)/Patent Under
Reexamination
TAKESHIMA ET AL.

Examiner

Brian E. Miller

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0008669	07-2001	Hara et al.	428/64.4
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	P	JP 09-245379	09-1997	Japan	Shinichi et al	---
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NON-PATENT DOCUMENTS

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